Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination		
09/284,578	MIYA ET AL.		
Examiner	Art Unit		
Edward J. Webman	1616		

CEARCHER									
SEARCHED									
Class	Subclass	Date	Examiner						
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INTERFERENCE SEARCHED							
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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